Supplementary

Nanostructured CeO₂ ultrathin film deposited by Langmuir Blodgett technique for

Highly Sensitive and Specific Detection of sub ppm level NO₂ gas at room temperature

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Table S1: Comparison with response and recovery time between our sensor and other CeO_2 sensors reported

Sample	Operating	Response	Response	Recovery	Ref
	temperature	with NO ₂	time	time	
Columnar CeO ₂	200° C	$\Delta R/R = 38$	not reported	not reported	[7]
nanostructures		for 1 ppm			
Spin coated cerium	200° C	6% at 5 ppm	5 sec	35 sec	[8]
oxide films					
Nanocubic CeO ₂ with	Room	16.59 % for	189 sec	1137 sec	[12]
{100} Polar Facets on	temperature	5 ppm			
Graphene					
RGO-CeO ₂ hybrids	Room	$\Delta I/I = 4.5$ for	600 sec	258 sec with	[13]
	temperature	10 ppm		UV light	
CeO ₂ by LB technique	Room	200% for 1	60 sec	600 sec	Our
	temperature	ppm			work



Fig. S1. Response of CeO₂ sensor with various concentration of NO₂ gas with stepwise injection represented by colored arrow: Red = 100 ppb, black = 200 ppb, blue = 400 ppb, green = 500 ppb, purple = 1 ppm, gray = 2ppm.



Fig. S2. Normalized response with various humidity condition



Fig. S3. Mott-Schottky plot of ultrathin CeO_2 on Si using 0.1 M KCl electrolyte at frequency of 1 kHz